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# Local Large-Margin Multi-Metric Learning for Face and Kinship Verification

Junlin Hu, Jiwen Lu, Senior Member, IEEE, Yap-Peng Tan, Senior Member, IEEE, Junsong Yuan, Senior Member, IEEE, and Jie Zhou, Senior Member, IEEE

Abstract—Metric learning has attracted wide attention in face and kinship verification and a number of such algorithms have been presented over the past few years. However, most existing metric learning methods learn only one Mahalanobis distance metric from a single feature representation for each face image and cannot make use of multiple feature representations directly. In many face-related tasks, we can easily extract multiple features for a face image to extract more complementary information, and it is desirable to learn distance metrics from these multiple features so that more discriminative information can be exploited than those learned from individual features. To achieve this, we present a large-margin multi-metric learning (LM<sup>3</sup>L) method for face and kinship verification, which jointly learns multiple global distance metrics under which the correlations of different feature representations of each sample are maximized, and the distance of each positive pair is less than a low threshold and that of each negative pair is greater than a high threshold. To better exploit the local structures of face images, we also propose a local metric learning (LML) and a local large-margin multi-metric learning  $(L^2M^3L)$  methods to learn a set of local metrics. Experimental results on three face datasets show that the proposed methods achieve very competitive results compared with the state-of-theart methods.

*Index Terms*—Local metric learning, multi-metric learning, face verification, kinship verification.

#### I. INTRODUCTION

**L** EARNING a promising distance metric from data itself plays an important role in computer vision and pattern recognition. Metric learning techniques have been widely used in many visual analysis applications such as face recognition [1], [2], image classification [3], human activity recognition [4], and kinship verification [5]. Over the past decade, a large number of metric learning algorithms have been

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Jiwen Lu and Jie Zhou are with the Department of Automation, Tsinghua University, State Key Lab of Intelligent Technologies and Systems, Tsinghua National Laboratory for Information Science and Technology (TNList), Beijing, 100084, China. E-mail: lujiwen@tsinghua.edu.cn; jzhou@tsinghua.edu.cn. proposed and some of them have been successfully applied to face and kinship verification [6], [1], [5], [7]. In facial image analysis, we are usually able to extract multiple feature representations for each face image and it is desirable to learn distance metrics from these multiple feature representations such that more discriminative information can be exploited than those learned from individual features. A widely used solution is to concatenate different features together into a new feature vector and then employ existing distance metric learning algorithms on this concatenated vector directly. However, this concatenation is not physically meaningful because each feature has its own statistical characteristic, and such a simple concatenation ignores the diversity of multiple features and cannot effectively explore the complementary information among the multiple features.

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In this paper, we first present a large-margin multi-metric learning (LM<sup>3</sup>L) method for face verification and kinship verification. Unlike the methods of learning a distance metric on concatenated feature vectors, we collaboratively learn multiple distance metrics from multiple feature representations of data, where one distance metric is learned for each feature and the correlations of different feature representations of each sample are maximized, and under the learned metric spaces the distance of each positive pair is less than a smaller threshold and that of each negative face pair is more than a larger threshold, respectively. In addition, we also propose two local distance metric learning approaches, i.e., local metric learning (LML) and a local large-margin multi-metric learning  $(L^2M^3L)$ , to better exploit the local manifold structures of face images. Experimental results on three widely used face datasets show that our methods can obtain competitive results compared with state-of-the-art methods. See Fig. 1 of [8] for the basic pipeline of our multi-metric learning methods.

This paper is an extension to our conference paper [8], where we only learn a global distance metric for each singleview feature of samples. The new contributions of this paper are summarized as: 1) we have presented a local metric learning (LML) for each single-view feature by jointly learning a global and several local metrics to better exploit the local manifold structure that face images usually lie on; 2) we have proposed a local large-margin multi-metric learning ( $L^2M^3L$ ) method by integrating the LML into the  $LM^3L$  method, and the  $LM^3L$  is a special case of the  $L^2M^3L$  method where only multiple global metrics are jointly learned; and 3) we have conducted more experiments on three datasets for face and kinship verification tasks to show the effectiveness of the proposed methods.

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# II. RELATED WORK

## A. Face and Kinship Verification

These days face verification under uncontrolled conditions is a mainstream task of face recognition [9], [1], [10], [2], [11], [12], [13], which aims to determine if two face images/videos are from the same subject or not. Kinship verification from facial images is another challenging face analysis problem [14], [15], [16], [17], [18], and its goal is to decide whether there is a kinship relation between two individuals via their face images. In recent years, many methods have been proposed for face and kinship verification under uncontrolled conditions [10], [6], [19], [20], [21], [22]. Most of these methods mainly focus on feature representation and similarity/metric learning, which are two important steps in the pipeline of the face/kinship verification. Typical feature descriptors include local binary pattern (LBP) [23], probabilistic elastic matching (PEM) [24], etc. The similarity/metric learning step aims to learn one or more metrics from the training data to help improve the verification accuracy [1], [19], [17], [20]. In this paper, we propose a multi-metric learning method to learn multiple distance metrics for face and kinship verification under uncontrolled conditions.

## B. Metric Learning

A number of metric learning methods have been introduced in the literature recently, and most of them seek an appropriate global distance metric to exploit discriminative information from the training samples. Representative metric learning methods include large margin nearest neighbor (LMNN) [25], information theoretic metric learning (ITML) [26], logistic discriminant metric learning (LDML) [1], pairwise constrained component analysis (PCCA) [27], neighborhood repulsed metric learning (NRML) [5], similarity metric learning (SM-L) [19], and deep metric learning [28], [29]. Recently several local metric learning methods [30], [31] have been proposed to model the local specificities of the data points by learning a set of local distance metrics for a single feature. While these methods have achieved encouraging performance in face verification, most of them learn one global metric or multiple local metrics from the single-view feature representation and cannot exploit multi-view feature representations directly. Unlike these single feature based methods, we present a multi-metric learning approach by collaboratively learning multiple global and local distance metrics to better exploit complementary information from multiple feature representations for face and kinship verification in the wild.

## III. LARGE-MARGIN MULTI-METRIC LEARNING

Before detailing our method, we first list the notations used in this paper. Bold capital letters, e.g.,  $\mathbf{X}_1$ ,  $\mathbf{X}_2$ , represent matrices, and bold lower case letters, e.g.,  $\mathbf{x}_1$ ,  $\mathbf{x}_2$ , represent column vectors. Given a training set containing N data points, i.e.,  $\mathcal{X} = {\mathbf{x}_i}_{i=1}^N$ , each data point of this set can be easily represented by the multiple types of features, e.g., color, texture, shape, etc. Let  $\mathcal{X}_k = {\mathbf{x}_i^k \in \mathbb{R}^{d_k}}_{i=1}^N$  be the k-th feature set of  $\mathcal{X}$  from the k-th type of feature representation, and let  $\mathbf{X}_k = [\mathbf{x}_1^k, \mathbf{x}_2^k, \cdots, \mathbf{x}_N^k]$  be the feature matrix of set  $\mathcal{X}_k$ , where  $\mathbf{x}_i^k$  is the feature vector of the data point  $\mathbf{x}_i$  in the *k*-th feature space,  $k = 1, 2, \cdots, K$ ; *K* is the total number of types of features; and  $d_k$  is feature dimension of  $\mathbf{x}_i^k$ .

## A. Problem Formulation

For a feature set  $\mathcal{X}_k = {\mathbf{x}_i^k \in \mathbb{R}^{d_k}}_{i=1}^N$  from the *k*-th feature representation, the squared Mahalanobis distance between a pair of samples  $\mathbf{x}_i^k$  and  $\mathbf{x}_i^k$  can be computed as:

$$d_{\mathbf{M}_{k}}^{2}(\mathbf{x}_{i}^{k},\mathbf{x}_{j}^{k}) = (\mathbf{x}_{i}^{k}-\mathbf{x}_{j}^{k})^{T}\mathbf{M}_{k}(\mathbf{x}_{i}^{k}-\mathbf{x}_{j}^{k}),$$
(1)

where  $\mathbf{M}_k \in \mathbb{R}^{d_k \times d_k}$  is a positive definite matrix.

We seek a distance metric  $\mathbf{M}_k$  such that the squared distance  $d_{\mathbf{M}_k}^2(\mathbf{x}_i^k, \mathbf{x}_j^k)$  for a face pair  $\mathbf{x}_i^k$  and  $\mathbf{x}_j^k$  in the *k*th feature space should be smaller than a given threshold  $\mu_k - \tau_k$  ( $\mu_k > \tau_k > 0$ ) if two samples are from the same subject, and larger than a threshold  $\mu_k + \tau_k$  if these two samples are from different subjects, which can be formulated as the following constraints:

$$y_{ij}\left(\mu_k - d_{\mathbf{M}_k}^2(\mathbf{x}_i^k, \mathbf{x}_j^k)\right) > \tau_k, \tag{2}$$

where pairwise label  $y_{ij} = 1$  if  $\mathbf{x}_i^k$  and  $\mathbf{x}_j^k$  are from the same category (or similar pair), and  $y_{ij} = -1$  if they are from different categories (or dissimilar pair). The parameter  $\mu_k$  is an absolute threshold to decide whether two samples are similar pair or not. The parameter  $\tau_k$  is a positive slack variable to guarantee a margin (i.e.,  $2\tau_k$ ) between a similar pair and a dissimilar pair.

To learn  $M_k$ , we define the constraints (2) by a hinge loss, and formulate the following objective function to learn the *k*-th distance metric, named single metric learning (SML):

$$\min_{\mathbf{M}_{k}} J_{k} = \sum_{i,j} h\Big(\tau_{k} - y_{ij}\big(\mu_{k} - d_{\mathbf{M}_{k}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})\big)\Big), \quad (3)$$

where  $h(x) = \max(x, 0)$  represents the hinge loss function. The objective function (3) penalizes the violation of the constraint  $d_{\mathbf{M}_k}^2(\mathbf{x}_i^k, \mathbf{x}_j^k) > \mu_k - \tau_k$  for a similar pair and that of the constraint  $d_{\mathbf{M}_k}^2(\mathbf{x}_i^k, \mathbf{x}_j^k) < \mu_k + \tau_k$  for a dissimilar pair by using the hinge loss.

Given a face image, it is easy to extract multiple features for each image for multiple feature fusion. These features extracted from the same face image are usually highly correlated to each other even if they characterize face images from different aspects [32]. For multiple feature fusion, these highly correlated information should be preserved because they usually reflect the intrinsic information of samples. An important principle to perform multi-feature metric learning is to jointly learn multiple distance metrics by preserving the correlation between different feature pairs. Motivated by the success of canonical correlation analysis (CCA), we propose a largemargin multi-metric learning method to seek the commonality of multiple feature representations, which is consistent to the CCA-based multiple feature fusion methods [32], [33].

The proposed large-margin multi-metric learning  $(LM^{3}L)$  method aims to learn K distance metrics  $\{M_{k} \in \mathbb{R}^{d_{k} \times d_{k}}\}_{k=1}^{K}$  for a multi-feature dataset, such that 1) the discriminative information from each single feature can be exploited as much as possible; and 2) the differences of different feature

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representations of each sample in the learned distance metrics are minimized, because different features of each sample share the same semantic label.

Since the difference computation of the sample  $\mathbf{x}_i$  from the k-th and  $\ell$ -th  $(1 \le k, \ell \le K, k \ne \ell)$  feature representations relies on the distance metrics  $\mathbf{M}_k$  and  $\mathbf{M}_\ell$ , which could be different in dimensions, it is infeasible to compute them directly. To address this, we use an alternative constraint to reflect the relationships of different feature representations. Since the distance between  $\mathbf{x}_i^k$  and  $\mathbf{x}_j^k$ , and that of  $\mathbf{x}_i^\ell$  and  $\mathbf{x}_j^\ell$  are expected to be as small as possible, hence, we formulate the following objective function to constrain the interactions of different distance metrics in our LM<sup>3</sup>L method:

$$\min_{\{\mathbf{M}_{k}, w_{k}\}_{k=1}^{K}} J = \sum_{k=1}^{K} w_{k} J_{k} 
+ \lambda \sum_{\substack{k,\ell=1\\k<\ell}}^{K} \sum_{i,j} \left( d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) - d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell}) \right)^{2},$$
s.t. 
$$\sum_{k=1}^{K} w_{k} = 1, w_{k} \ge 0, \lambda > 0,$$
(4)

where  $w_k$  is a nonnegative weighting parameter to reflect the importance of the k-th feature in the whole objective function, and  $\lambda$  weights the pairwise difference of the distance between two samples  $\mathbf{x}_i$  and  $\mathbf{x}_j$  in the learned distance metrics  $\mathbf{M}_k$ and  $\mathbf{M}_{\ell}$ . The physical meaning of (4) is that we aim to learn K distance metrics  $\{\mathbf{M}_k\}_{k=1}^K$  under which the difference of feature representations of each pair of face samples is enforced to be as small as possible. The reason that a sample  $x_i$  should be close in different feature spaces (k and  $\ell$ ) is to seek a commonality of multiple features and make all the features more robust, which is consistent to the CCA-based multiple feature fusion methods.

Having obtained the multiple distance metrics  $\{\mathbf{M}_k\}_{k=1}^K$ and their weights  $\{w_k\}_{k=1}^K$ , the distance between two multifeature data points  $\mathbf{x}_i$  and  $\mathbf{x}_j$  under the global metrics learned by the LM<sup>3</sup>L is computed as:

$$d_{\mathrm{LM}^{3}\mathrm{L}}^{2}(\mathbf{x}_{i}, \mathbf{x}_{j}) = \sum_{k=1}^{K} w_{k} \ d_{\mathbf{M}_{k}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})$$
$$= \sum_{k=1}^{K} w_{k} \ (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k})^{T} \mathbf{M}_{k}(\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k}).$$
(5)

The trivial solution of (4) is  $w_k = 1$ , which corresponds to the minimum  $J_k$  over different feature representations, and  $w_k = 0$  otherwise. This solution means that only one single feature that yields the best verification accuracy is selected, which does not satisfy our objective on exploring the complementary property of multi-feature data.

To address this shortcoming, we modify  $w_k$  to be  $w_k^p$  (p >

1), then the new objective function is rewritten as:

$$\min_{\{\mathbf{M}_k, w_k\}_{k=1}^K} J = \sum_{k=1}^K w_k^p J_k 
+ \lambda \sum_{\substack{k,\ell=1\\k<\ell}}^K \sum_{\substack{i,j}} \left( d_{\mathbf{M}_k}(\mathbf{x}_i^k, \mathbf{x}_j^k) - d_{\mathbf{M}_\ell}(\mathbf{x}_i^\ell, \mathbf{x}_j^\ell) \right)^2,$$
s.t. 
$$\sum_{k=1}^K w_k = 1, \ w_k \ge 0, \ \lambda > 0.$$
(6)

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When p = 1, it is not easy to obtain the optimal  $w_k$ . From (17), we obtain  $J_1 = J_2 = \cdots = J_K = \eta$ , then  $w_k$  can be an arbitrary value in the interval [0, 1]. Thus, the trivial solution is  $w_k = 1$  for the minimum  $J_k$  over different feature representations, and  $w_k = 1$  otherwise. When p > 1, we obtain a closed-form solution of  $w_k$  by (19), and each feature representation has a particular contribution to the final metric learning.

#### B. Alternating Optimization

To the best of our knowledge, it is non-trivial to seek a global optimal solution to (6) because there are K metrics to be learned simultaneously. In this work, we employ an iterative method by using the alternating optimization method to obtain a local optimal solution. The alternating optimization learns  $\mathbf{M}_k$  and  $w_k$  in an iterative manner. In our experiments, we randomly select the order of different features to start the optimization procedure and our tests show that the influence of this order is not critical to the final verification performance.

1) Step 1: Fix  $\mathbf{w} = [w_1, w_2, \dots, w_K]$ , Update  $\mathbf{M}_k$ : With the fixed  $\mathbf{w}$ , we can cyclically optimize (6) over different features. We sequentially optimize  $\mathbf{M}_k$  with the fixed  $\mathbf{M}_1$ ,  $\dots$ ,  $\mathbf{M}_{k-1}$ ,  $\mathbf{M}_{k+1}$ ,  $\dots$ ,  $\mathbf{M}_K$ . Hence, (6) can be rewritten as:

$$\min_{\mathbf{M}_{k}} J = A_{k} + w_{k}^{p} J_{k}$$

$$+ \lambda \sum_{\substack{\ell=1\\\ell \neq k}}^{K} \sum_{i,j} \left( d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) - d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell}) \right)^{2}, \quad (7)$$

where  $A_k$  is a constant term.

To learn the distance metric  $M_k$ , we employ a gradientbased scheme. After some algebraic simplification, we can obtain the gradient as:

$$\frac{\partial J}{\partial \mathbf{M}_{k}} = w_{k}^{p} \sum_{i,j} y_{ij} h'(z_{ij}) \mathbf{C}_{ij}^{k} + \lambda \sum_{\substack{\ell=1\\\ell \neq k}}^{K} \sum_{i,j} \left( 1 - \frac{d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell})}{d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})} \right) \mathbf{C}_{ij}^{k}, \quad (8)$$

where  $z_{ij}$  and  $\mathbf{C}_{ij}^k$  can be calculated respectively by:

$$\mathbf{C}_{ij}^{k} = (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k})(\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k})^{T}, \qquad (9)$$

$$z_{ij} = \tau_k - y_{ij} \left( \mu_k - d^2_{\mathbf{M}_k}(\mathbf{x}_i^k, \mathbf{x}_j^k) \right). \tag{10}$$

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 $\mathbf{C}_{ii}^k$  denotes the outer product of pairwise differences. h'(x)is the derivative of h(x), h'(0) = 0 at the non-differentiable point. In addition, we use derivations given as:

$$\frac{\partial}{\partial \mathbf{M}_k} d_{\mathbf{M}_k}(\mathbf{x}_i^k, \mathbf{x}_j^k) = \frac{1}{2 \ d_{\mathbf{M}_k}(\mathbf{x}_i^k, \mathbf{x}_j^k)} \ \mathbf{C}_{ij}^k, \tag{11}$$

$$\frac{\partial}{\partial \mathbf{M}_{k}} \left( d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) - d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell}) \right)^{2} \\
= 2 \left( d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) - d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell}) \right) \frac{\partial}{\partial \mathbf{M}_{k}} d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \\
= \left( 1 - \frac{d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell})}{d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})} \right) \mathbf{C}_{ij}^{k}.$$
(12)

Then, matrix  $\mathbf{M}_k$  can be obtained by using a gradient descent algorithm:

$$\mathbf{M}_{k} = \mathbf{M}_{k} - \beta \ \frac{\partial J}{\partial \mathbf{M}_{k}},\tag{13}$$

where  $\beta$  is the learning rate.

In practice, directly optimizing the Mahalanobis distance metric  $\mathbf{M}_k$  may suffer slow convergence and overfitting problems if data is very high-dimensional and the number of training samples is insufficient. Therefore, we propose an alternative method to jointly perform dimensionality reduction and metric learning, which means a low-rank linear projection matrix  $\mathbf{L}_k \in \mathbb{R}^{s_k \times d_k}$   $(s_k < d_k)$  is learned to project each sample  $\mathbf{x}_{i}^{k}$  from the high-dimensional input space to a low-dimensional embedding space, where the distance metric  $\mathbf{M}_{k} = \mathbf{L}_{k}^{T} \mathbf{L}_{k}$ . Then, we differentiate the objective function J with respect to  $\mathbf{L}_k$ , and obtain the gradient as follows:

$$\frac{\partial J}{\partial \mathbf{L}_{k}} = 2\mathbf{L}_{k} \left( w_{k}^{p} \sum_{i,j} y_{ij} h'(z_{ij}) \mathbf{C}_{ij}^{k} + \lambda \sum_{\substack{\ell=1\\\ell \neq k}}^{K} \sum_{i,j} \left( 1 - \frac{d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell})}{d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})} \right) \mathbf{C}_{ij}^{k} \right).$$
(14)

Lastly,  $L_k$  can be obtained by a gradient descent rule:

$$\mathbf{L}_{k} = \mathbf{L}_{k} - \beta \ \frac{\partial J}{\partial \mathbf{L}_{k}}.$$
 (15)

To make sure the learned metric  $M_k$  is a positive semidefinite matrix after each iteration, we clip the spectrum of  $\mathbf{M}_k$  =  $\mathbf{L}_k^T \mathbf{L}_k$  by singular value decomposition.

2) Step 2: Fix  $\{\mathbf{M}_k\}_{k=1}^K$ , Update  $\mathbf{w} = [w_1, w_2, \cdots, w_K]$ : Then, we update **w** with the fixed  $\{\mathbf{M}_k\}_{k=1}^{K}$  by the method of Lagrange multipliers. We construct a Lagrange function as:

$$L(\mathbf{w},\eta) = \sum_{k=1}^{K} w_k^p J_k + A - \eta \left(\sum_{k=1}^{K} w_k - 1\right), \quad (16)$$

in which A is a constant term.

Let 
$$\frac{\partial L(\mathbf{w},\eta)}{\partial w_k} = 0$$
 and  $\frac{\partial L(\mathbf{w},\eta)}{\partial \eta} = 0$ , we have

$$\frac{\partial L(\mathbf{w},\eta)}{\partial w_k} = p \ w_k^{p-1} \ J_k - \eta = 0, \tag{17}$$

$$\frac{\partial L(\mathbf{w},\eta)}{\partial \eta} = \sum_{k=1}^{K} w_k - 1 = 0.$$
(18)

## Algorithm 1: LM<sup>3</sup>L

**Input**: Training set  $\{\mathcal{X}_k\}_{k=1}^K$  from K views; Learning rate  $\beta$ ; Parameter p,  $\lambda$ ,  $\mu_k$  and  $\tau_k$ ; Total iterative number T; Convergence error  $\varepsilon$ . **Output**: Multiple metrics:  $\mathbf{M}_1, \mathbf{M}_2, \cdots, \mathbf{M}_K$ ; and weights:  $w_1, w_2, \cdots, w_K$ . // Initialization: Initialize  $\mathbf{L}_k = \mathbf{I}^{s_k \times d_k}$ ,  $w_k = 1/K, \ k = 1, \cdots, K.$ // Alternating optimization: for  $t = 1, 2, \dots, T$ , do for  $k = 1, 2, \dots, K$ , do Compute  $\mathbf{L}_k$  by (14) and (15). end for Compute w according to (19). Computer  $J^{(t)}$  via (6).  $\text{ if } t>1 \ \text{and} \ |J^{(t)}-J^{(t-1)}|<\varepsilon \\$ Go to Output. end if end for // Output distance metrics and weights:  $\mathbf{M}_k = \mathbf{L}_k^T \mathbf{L}_k, \ k = 1, 2, \cdots, K.$ 

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According to (17) and (18),  $w_k$  can be updated as:

Output  $\mathbf{M}_1, \mathbf{M}_2, \cdots, \mathbf{M}_K$  and  $\mathbf{w}$ .

$$w_k = \frac{\left(1/J_k\right)^{1/(p-1)}}{\sum\limits_{k=1}^{K} \left(1/J_k\right)^{1/(p-1)}}.$$
(19)

We repeat the above two steps until the algorithm meets a certain convergence condition. The proposed LM<sup>3</sup>L algorithm is summarized in Algorithm 1, where  $\mathbf{I} \in \mathbb{R}^{s_k \times d_k}$  is a matrix with 1's on the diagonal and zeros elsewhere.

#### IV. LOCAL LARGE-MARGIN MULTI-METRIC LEARNING

## A. Local Metric Learning

Considering a single feature set  $\mathcal{X}_k = \{\mathbf{x}_i^k \in \mathbb{R}^{d_k}\}_{i=1}^N$ of  $\mathcal{X}$  which is represented by the k-th type of feature, the squared Mahalanobis distance between a pair of samples  $\mathbf{x}_{i}^{k}$  and  $\mathbf{x}_{i}^{k}$  under a specific local metric  $\mathbf{M}_{k}^{(q)} \in \mathbb{R}^{d_{k} \times d_{k}}$ ,  $q = 1, 2, \cdots, Q_k$ , can be calculated by:

$$d_{\mathbf{M}_{k}^{(q)}}^{2}(\mathbf{x}_{i}^{k},\mathbf{x}_{j}^{k}) = (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k})^{T}\mathbf{M}_{k}^{(q)}(\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k}),$$
(20)

where  $\mathbf{M}_{k}^{(q)} \in \mathbb{R}^{d_k \times d_k}$  is a positive semi-definite (PSD) matrix  $(\mathbf{M}_{k}^{(q)} \succeq \mathbf{0})$ , and  $Q_{k}$  is the total number of local distance metrics corresponding to the k-th type of feature representation.

Based on a set of local distance metrics  $\{\mathbf{M}_{k}^{(q)}\}_{q=1}^{Q_{k}}$ , the distance of each sample pair  $\mathbf{x}_{i}^{k}$  and  $\mathbf{x}_{j}^{k}$  can be defined as a convex combination by soft dividing the whole input space

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into different regions:

$$d_{\{\mathbf{M}_{k}^{(q)}\}_{q=1}^{Q_{k}}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})$$

$$= \sum_{q=1}^{Q_{k}} \alpha_{k}^{(q)}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \ d_{\mathbf{M}_{k}^{(q)}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})$$

$$= (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k})^{T} \left(\sum_{q=1}^{Q_{k}} \alpha_{k}^{(q)}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})\mathbf{M}_{k}^{(q)}\right) (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k}), \quad (21)$$

where  $\alpha_k^{(q)}(\mathbf{x}_i^k, \mathbf{x}_j^k)$  is nonnegative weight to measure the importance of the q-th local metric to both  $\mathbf{x}_i^k$  and  $\mathbf{x}_j^k$ , which ensures the learned dissimilarity function of  $\mathbf{x}_i^k$  and  $\mathbf{x}_j^k$  to be local. In addition, a global metric  $\mathbf{M}_k^{(0)}$  with a positive constant weight  $\alpha_k^{(0)}(\mathbf{x}_i^k, \mathbf{x}_j^k) = c_k$  is complemented into (21) to handle the part of the dissimilarity function shared by the whole input space. Thus, the final distance (or dissimilarity function) of a pair  $\mathbf{x}_i^k$  and  $\mathbf{x}_j^k$  is given as:

$$\begin{aligned} &d_{\mathbf{M}_{k}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \\ &= (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k})^{T} \left( \sum_{q=0}^{Q_{k}} \alpha_{k}^{(q)}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \mathbf{M}_{k}^{(q)} \right) (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k}) \\ &= (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k})^{T} \mathbf{M}_{k}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k}), \end{aligned}$$
(22)

where the PSD matrix  $\mathbf{M}_k(\cdot, \cdot) \in \mathbb{R}^{d_k \times d_k}$  is a matrix-valued function, and it is weighted by  $Q_k + 1$  matrices for a sample pair  $\mathbf{x}_i^k$  and  $\mathbf{x}_j^k$  as follows:

$$\mathbf{M}_{k}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) = \left(\sum_{q=0}^{Q_{k}} \alpha_{k}^{(q)}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \mathbf{M}_{k}^{(q)}\right).$$
(23)

Importantly, the weight  $\alpha_k^{(q)}(\mathbf{x}_i^k, \mathbf{x}_j^k)$  in the local distance function (23) is defined as:

$$\alpha_k^{(q)}(\mathbf{x}_i^k, \mathbf{x}_j^k) = \begin{cases} c_k & \text{if } q = 0\\ u_k^{(q)}(\mathbf{x}_i^k) \ u_k^{(q)}(\mathbf{x}_j^k) & \text{otherwise} \end{cases}, \quad (24)$$

in which  $u_k^{(q)}(\mathbf{x}_i^k)$  is a gating model to assign weight to the q-th local distance metric in a data-dependent way. In our experiments, we adopt a softmax gating function [34], which is given as follows:

$$u_{k}^{(q)}(\mathbf{x}_{i}^{k}) = \frac{\exp\left(\mathbf{v}_{k}^{(q)^{T}}\mathbf{x}_{i}^{k} + b_{k}^{(q)}\right)}{\sum_{m=1}^{Q_{k}}\exp\left(\mathbf{v}_{k}^{(m)^{T}}\mathbf{x}_{i}^{k} + b_{k}^{(m)}\right)},$$
(25)

for the q-th local metric, where  $\mathbf{v}_k^{(q)}$  and  $b_k^{(q)}$  are the weighting and bias parameters of this gating function respectively, and we have  $u_k^{(q)}(\mathbf{x}_i^k) \ge 0$  for  $1 \le q \le Q_k$  and  $1 \le k \le K$ . This gating function parametrized by the parameters  $\{\mathbf{v}_k^{(q)}, b_k^{(q)}\}_{q=1}^{Q_k}$ is used to compute the weight (or probability) that an input vector  $\mathbf{x}_i^k$  belongs to each local distance metric space. For example, a face image can be assigned to multiple metric spaces (e.g., age, expression, gender, race, etc.) with different weights. After having learned the parameters  $\{\mathbf{v}_k^{(q)}, b_k^{(q)}\}_{q=1}^{Q_k}$ on the training data, this softmax gating function can be easily applied to other input vectors in a data-dependent way. Then, we formulate our local metric learning (LML) method with respect to the single feature type k under the same large margin framework as used in (3):

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$$\min_{\{\mathbf{M}_{k}^{(q)}\}_{q=0}^{Q_{k}}, \{\mathbf{v}_{k}^{(q)}, b_{k}^{(q)}\}_{q=1}^{Q_{k}}} J_{k} = \sum_{i,j} h\Big(\tau_{k} - y_{ij}\big(\mu_{k} - d_{\mathbf{M}_{k}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})\big)\Big). \quad (26)$$

The objective function (26) is not jointly convex to  $\{\mathbf{M}_{k}^{(q)}\}_{q=0}^{Q_{k}}$ and  $\{\mathbf{v}_{k}^{(q)}, b_{k}^{(q)}\}_{q=1}^{Q_{k}}$ , and it is non-trivial to find a global solution. To obtain these parameters, we employ the alternating optimization strategy and the gradient descent based method to achieve the local optimal solution.

1) Step 1: Fix  $\{\mathbf{M}_{k}^{(r)}\}_{r=0}^{Q_{k}} \setminus \mathbf{M}_{k}^{(q)}$  and  $\{\mathbf{v}_{k}^{(r)}, b_{k}^{(r)}\}_{r=1}^{Q_{k}}$ , Update  $\mathbf{M}_{k}^{(q)}$ : The partial derivative of  $J_{k}$  with regard to  $\mathbf{M}_{k}^{(q)}$ ,  $0 \leq q \leq Q_{k}$ , can be calculated by:

$$\frac{\partial J_k}{\partial \mathbf{M}_k^{(q)}} = \sum_{i,j} y_{ij} h'(z_{ij}) \alpha_k^{(q)}(\mathbf{x}_i^k, \mathbf{x}_j^k) \mathbf{C}_{ij}^k, \qquad (27)$$

where  $z_{ij} = \tau_k - y_{ij} (\mu_k - d_{\mathbf{M}_k}^2(\mathbf{x}_i^k, \mathbf{x}_j^k))$ , and  $\mathbf{C}_{ij}^k$  is the outer product of pairwise differences given by (9).

2) Step 2: Fix  $\{\mathbf{M}_{k}^{(r)}\}_{r=0}^{Q_{k}}$  and  $\{\mathbf{v}_{k}^{(r)}, b_{k}^{(r)}\}_{r=1}^{Q_{k}} \setminus \{\mathbf{v}_{k}^{(q)}, b_{k}^{(q)}\}, Update \mathbf{v}_{k}^{(q)} and b_{k}^{(q)}$ : The partial derivative of  $J_{k}$  with regard to  $\mathbf{v}_{k}^{(q)}$  and  $b_{k}^{(q)}$  can be computed by:

$$\frac{\partial J_k}{\partial \mathbf{v}_k^{(q)}} = \sum_{i,j} y_{ij} h'(z_{ij}) \sum_{m=1}^{Q_k} u_k^{(m)}(\mathbf{x}_i^k) u_k^{(m)}(\mathbf{x}_j^k) d_{\mathbf{M}_k^{(m)}}^2(\mathbf{x}_i^k, \mathbf{x}_j^k) \\
\times \left( [\delta(q-m) - u_k^{(q)}(\mathbf{x}_i^k)] \mathbf{x}_i^k + [\delta(q-m) - u_k^{(q)}(\mathbf{x}_j^k)] \mathbf{x}_j^k \right),$$
(28)

$$\frac{\partial J_k}{\partial b_k^{(q)}} = \sum_{i,j} y_{ij} h'(z_{ij}) \sum_{m=1}^{Q_k} u_k^{(m)}(\mathbf{x}_i^k) u_k^{(m)}(\mathbf{x}_j^k) d_{\mathbf{M}_k^{(m)}}^2(\mathbf{x}_i^k, \mathbf{x}_j^k) \\
\times \left( \delta(q-m) - u_k^{(q)}(\mathbf{x}_i^k) + \delta(q-m) - u_k^{(q)}(\mathbf{x}_j^k) \right),$$
(29)

in which the delta function  $\delta(q-m) = 1$  if q = m and 0 otherwise for  $q = 1, 2, \dots, Q_k$ .

We repeat the above two steps until the algorithm reaches certain convergence conditions. Moreover, we also decompose  $\mathbf{M}_{k}^{(q)}$  into  $\mathbf{M}_{k}^{(q)} = \mathbf{L}_{k}^{(q)^{T}} \mathbf{L}_{k}^{(q)}$  in the objective function (26) to reduce the number of parameters in optimization.

## B. Local Large-Margin Multi-Metric Learning

Local metric learning (LML) only learns a set of local distance metrics for each type of feature such that it cannot exploit discriminative information of other types of features. To utilize multiple features, we also propose a local large-margin multi-metric learning ( $L^2M^3L$ ) method by integrating the local metric learning (LML) (26) and the large-margin multi-metric learning (LM<sup>3</sup>L) (6) into a unified framework.

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Algorithm 2: L<sup>2</sup>M<sup>3</sup>L

**Input**: Training set  $\{\mathcal{X}_k\}_{k=1}^K$  from K views; Local metric number  $\{Q_k\}_{k=1}^K$ ; Learning rate  $\beta$ ; Parameter p,  $\lambda$ ,  $\mu_k$ ,  $\tau_k$ ; Total iterative number T; Convergence error  $\varepsilon$ . **Output**: Metrics:  $\left\{ \{\mathbf{M}_k^{(q)}\}_{q=0}^{Q_k} \right\}_{k=1}^K$ ; Weights:  $\{w_k\}_{k=1}^K$ ; Gating model:  $\left\{ \{ \mathbf{v}_{k}^{(q)}, b_{k}^{(q)} \}_{q=1}^{Q_{k}} \right\}_{k=1}^{K}$ . // Initialization: Initialization: Initialize  $\{\mathbf{M}_{k}^{(q)} = \mathbf{I}^{d_{k} \times d_{k}}\}_{q=0}^{Q_{k}}$  and  $w_{k} = 1/K$ ,  $\{\mathbf{v}_{k}^{(q)} \sim U(0,1), b_{k}^{(q)} = 0\}_{q=1}^{Q_{k}}, k = 1, 2, \cdots, K$ . // Alternating optimization: for  $t = 1, 2, \dots, T$ , do for  $k = 1, 2, \dots, K$ , do for  $q = 0, 1, \dots, Q_k$ , do // Step 1: Update  $\mathbf{M}_{\mu}^{(q)}$ Calculate  $\partial J/\partial \mathbf{M}_{k}^{(q)}$  by (31).  $\mathbf{M}_{k}^{(q)} \longleftarrow \mathbf{M}_{k}^{(q)} - \beta \ \partial J/\partial \mathbf{M}_{k}^{(q)}$ . end for end for for  $k = 1, 2, \cdots, K$ , do for  $q = 1, 2, \cdots, Q_k$ , do  $\begin{array}{l} \begin{array}{l} & (1,2,7) \\ & (1) \\ \hline \\ & (1) \\ \hline \\ & \text{Compute } \partial J / \partial \mathbf{v}_k^{(q)} \text{ by } (32). \end{array} \end{array}$ Compute  $\partial J/\partial b_k^{(q)}$  by (32).  $\mathbf{v}_k^{(q)} \leftarrow \mathbf{v}_k^{(q)} - \beta \ \partial J/\partial \mathbf{v}_k^{(q)}$ .  $b_k^{(q)} \leftarrow b_k^{(q)} - \beta \ \partial J/\partial b_k^{(q)}$ . end for end for // Step 3: Update  $\{w_k\}_{k=1}^{K}$ Calculate  $\{w_k\}_{k=1}^K$  by (34). Calculate objective  $J^{(t)}$  using (30). if t > 1 and  $|J^{(t)} - J^{(t-1)}| < \varepsilon$ Go to **Output**. end if end for Output  $\left\{ \{\mathbf{M}_{k}^{(q)}\}_{q=0}^{Q_{k}}, \{\mathbf{v}_{k}^{(q)}, b_{k}^{(q)}\}_{q=1}^{Q_{k}}, w_{k} \right\}_{k=1}^{K}$ 

The objective function of the  $L^2M^3L$  is formulated as:

$$\min_{\left\{\{\mathbf{M}_{k}^{(q)}\}_{q=0}^{Q_{k}}, \ \mathbf{t}_{\mathbf{x}_{k}^{(q)}}^{(q)}, \ b_{k}^{(q)}\}_{q=1}^{Q_{k}}, \ w_{k}\right\}_{k=1}^{K} J = \left\{\{\mathbf{M}_{k}^{(q)}\}_{q=0}^{Q_{k}}, \ \mathbf{t}_{\mathbf{x}_{k}^{(q)}}^{(q)}\}_{k=1}^{Q_{k}}, \ w_{k}^{(q)}\right\}_{k=1}^{K} \sum_{k=1}^{K} w_{k}^{p} J_{k} + \lambda \sum_{\substack{k,\ell=1\\k<\ell}}^{K} \sum_{k=1}^{K} \sum_{i,j}^{K} \left(d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) - d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell})\right)^{2},$$
s.t. 
$$\sum_{k=1}^{K} w_{k} = 1, \ w_{k} \ge 0, \ \lambda > 0.$$
(30)

It is obviously that the  $LM^{3}L$  is a special case of the  $L^{2}M^{3}L$  method where only several global distance metrics are jointly solved. To minimize the optimization problem (30), we adopt similar methods as used in both  $LM^{3}L$  and LML.

1) Step 1: Fix  $\left\{ \{\mathbf{M}_{k}^{(r)}\}_{r=0}^{Q_{k}}, \{\mathbf{v}_{k}^{(r)}, b_{k}^{(r)}\}_{r=1}^{Q_{k}}, w_{k} \right\}_{k=1}^{K} \setminus \mathbf{M}_{k}^{(q)}$ , Update  $\mathbf{M}_{k}^{(q)}$ : We update  $\mathbf{M}_{k}^{(q)}$ ,  $1 \leq k \leq K$ ,  $0 \leq q \leq Q_{k}$ , by fixing other parameters. The partial derivative of J with regard to  $\mathbf{M}_{k}^{(q)}$  can be calculated by:

$$\frac{\partial J}{\partial \mathbf{M}_{k}^{(q)}} = w_{k}^{p} \sum_{i,j} y_{ij} h'(z_{ij}) \alpha_{k}^{(q)}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \mathbf{C}_{ij}^{k} + \lambda \sum_{\substack{\ell=1\\\ell\neq k}}^{K} \sum_{i,j} \left( 1 - \frac{d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell})}{d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})} \right) \alpha_{k}^{(q)}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \mathbf{C}_{ij}^{k}, \quad (31)$$

where  $z_{ij} = \tau_k - y_{ij} (\mu_k - d_{\mathbf{M}_k}^2 (\mathbf{x}_i^k, \mathbf{x}_j^k))$ , and  $\mathbf{C}_{ij}^k$  is the outer product of pairwise differences given by (9).

2) Step 2: Fix  $\left\{ \{\mathbf{M}_{k}^{(r)}\}_{r=0}^{Q_{k}}, \{\mathbf{v}_{k}^{(r)}, b_{k}^{(r)}\}_{r=1}^{Q_{k}}, w_{k} \right\}_{k=1}^{K} \setminus \{\mathbf{v}_{k}^{(q)}, b_{k}^{(q)}\}, Update \mathbf{v}_{k}^{(q)} and b_{k}^{(q)}$ : The partial derivative of J with respect to  $\mathbf{v}_{k}^{(q)}$  and  $b_{k}^{(q)}, 1 \leq k \leq K, 1 \leq q \leq Q_{k}$ , can be computed by (32) and (33), where  $z_{ij} = \tau_{k} - y_{ij}(\mu_{k} - d_{\mathbf{M}_{k}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}))$ .

3) Step 3: Fix  $\left\{ \{\mathbf{M}_{k}^{(r)}\}_{r=0}^{Q_{k}}, \{\mathbf{v}_{k}^{(r)}, b_{k}^{(r)}\}_{r=1}^{Q_{k}} \right\}_{k=1}^{K}$ , Update  $\{w_{k}\}_{k=1}^{K}$ : Following the same procedures as in LM<sup>3</sup>L, we update  $w_{k}$  by utilizing the method of Lagrange multipliers. In this fashion, the closed-form solution can be obtained, and the  $w_{k}, 1 \leq k \leq K$ , is given by:

$$w_k = \frac{\left(1/J_k\right)^{1/(p-1)}}{\sum\limits_{k=1}^{K} \left(1/J_k\right)^{1/(p-1)}}.$$
(34)

Then, we alternately update above three steps until the proposed  $L^2M^3L$  method reaches a certain convergence condition, and then we will find the optimal solution,  $\{\mathbf{M}_k^{(q)}\}_{q=0}^{Q_k}, \{\mathbf{v}_k^{(q)}, b_k^{(q)}\}_{q=1}^{Q_k}, w_k, k = 1, 2, \cdots, K$ , of the  $L^2M^3L$  method. The Algorithm 2 lists the main steps of the  $L^2M^3L$  method.

After obtaining the multiple local and global distance metrics:  $\{\mathbf{M}_{k}^{(q)}\}_{q=0}^{Q_{k}}$ , gating model:  $\{\mathbf{v}_{k}^{(q)}, b_{k}^{(q)}\}_{q=1}^{Q_{k}}$ , and weight  $w_{k}$  for all the  $k = 1, 2, \dots, K$ , the distance of two multifeature data points  $\mathbf{x}_{i}$  and  $\mathbf{x}_{j}$  under the learned local metrics by  $\mathrm{L}^{2}\mathrm{M}^{3}\mathrm{L}$  can be calculated as follows:

$$d_{\mathrm{L}^{2}\mathrm{M^{3}L}}^{2}(\mathbf{x}_{i}, \mathbf{x}_{j})$$

$$= \sum_{k=1}^{K} w_{k} (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k})^{T} \left( \sum_{q=0}^{Q_{k}} \alpha_{k}^{(q)}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \mathbf{M}_{k}^{(q)} \right) (\mathbf{x}_{i}^{k} - \mathbf{x}_{j}^{k})$$

$$= \sum_{k=1}^{K} w_{k} d_{\mathbf{M}_{k}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}).$$
(35)

## V. EXPERIMENTS

To evaluate the effectiveness of the proposed  $LM^{3}L$ , LML and  $L^{2}M^{3}L$  methods, we conducted face and kinship verification under unconstrained conditions on three real-world face datasets, i.e., the Labeled Faces in the Wild (LFW) [9], the YouTube Faces (YTF) [10], and the KinFaceW-II [5].

**Baseline:** We evaluated the proposed methods with three baseline methods using different metric learning strategies:

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$$\begin{aligned} \frac{\partial J}{\partial \mathbf{v}_{k}^{(q)}} &= w_{k}^{p} \sum_{i,j} y_{ij} h'(z_{ij}) \sum_{m=1}^{Q_{k}} u_{k}^{(m)}(\mathbf{x}_{i}^{k}) u_{k}^{(m)}(\mathbf{x}_{j}^{k}) d_{\mathbf{M}_{k}^{(m)}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \Big( \left[ \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) \right] \mathbf{x}_{i}^{k} + \left[ \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{j}^{k}) \right] \mathbf{x}_{j}^{k} \Big) \\ & \lambda \sum_{\substack{\ell=1\\\ell\neq k}}^{K} \sum_{i,j} \left( 1 - \frac{d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell})}{d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k})} \right) \sum_{m=1}^{Q_{k}} u_{k}^{(m)}(\mathbf{x}_{i}^{k}) u_{k}^{(m)}(\mathbf{x}_{i}^{k}) d_{\mathbf{M}_{k}^{(m)}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \Big( \left[ \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) \right] \mathbf{x}_{i}^{k} + \left[ \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) \right] \mathbf{x}_{j}^{k} \Big) \\ &= \sum_{i,j} \left( w_{k}^{p} y_{ij} h'(z_{ij}) + \lambda \sum_{\substack{\ell=1\\\ell\neq k}}^{K} \left( 1 - \frac{d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell}) \right) \right) \\ &\times \sum_{m=1}^{Q_{k}} u_{k}^{(m)}(\mathbf{x}_{i}^{k}) u_{k}^{(m)}(\mathbf{x}_{i}^{k}) d_{\mathbf{M}_{k}^{(m)}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \Big( \left[ \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) \right] \mathbf{x}_{i}^{k} + \left[ \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) \right] \mathbf{x}_{j}^{k} \right) \\ & \delta J \\ &= \sum_{m=1}^{Q_{k}} u_{k}^{(m)}(\mathbf{x}_{i}^{k}) u_{k}^{(m)}(\mathbf{x}_{i}^{k}) d_{\mathbf{M}_{k}^{(m)}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \Big( \left[ \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) \right] \mathbf{x}_{i}^{k} + \left[ \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) \right] \mathbf{x}_{j}^{k} \right) \\ & \delta J \\ &= \sum_{m=1}^{Q_{k}} u_{k}^{(m)}(\mathbf{x}_{i}^{k}) u_{k}^{(m)}(\mathbf{x}_{i}^{k}) d_{\mathbf{M}_{k}^{(m)}}^{2}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \Big( \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) + \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) \Big) \\ & \delta J \\ &= \sum_{i,j} \left( 1 - \frac{d_{\mathbf{M}_{k}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{\ell}) \right) \sum_{m=1}^{Q_{k}} u_{k}^{(m)}(\mathbf{x}_{i}^{k}) u_{k}^{(m)}(\mathbf{x}_{i}^{k}) d_{\mathbf{M}_{k}^{(m)}}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \Big) \\ & \delta J \\ &= \sum_{i,j} \left( w_{k}^{p} y_{ij} h'(z_{ij}) + \lambda \sum_{\substack{\ell=1\\\ell\neq k}}^{K} \left( 1 - \frac{d_{\mathbf{M}_{\ell}}(\mathbf{x}_{i}^{\ell}, \mathbf{x}_{j}^{\ell}) \right) \right) \\ & \times \sum_{m=1}^{Q_{k}} u_{k}^{(m)}(\mathbf{x}_{i}^{k}) u_{k}^{(m)}(\mathbf{x}_{i}^{k}, \mathbf{x}_{j}^{k}) \Big) \left( \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) + \delta(q-m) - u_{k}^{(q)}(\mathbf{x}_{i}^{k}) \right) \right) \\ & \times \sum_{m=1}^{Q_{k}} u_{k}^{(m)}(\mathbf{x}_{i}^{k}) u_{k}^{(m)}($$

- Single Metric Learning (SML): we learned a single distance metric by using objective function (3) with singleview feature representation;
- Concatenated Metric Learning (CML): we first concatenated different feature representations into a long feature vector and then employed objective function (3) to learn a distance metric;
- Individual Metric Learning (IML): we learned the distance metric for each feature representation under the objective function (3) and then adopted the same weight (i.e.,  $w_k = 1/K$ ) to calculate the dissimilarity between a pair of face images by (5).

In addition, several free parameters p,  $\beta$ ,  $\lambda$ ,  $\mu_k$ ,  $\tau_k$ ,  $Q_k$  and  $c_k$  of our LM<sup>3</sup>L, LML and L<sup>2</sup>M<sup>3</sup>L methods were empirically set as 2, 0.001, 0.1, 5, 1, 3 and 1 for all the  $k = 1, 2, \dots, K$  respectively, unless stated otherwise. The following subsections detail the experimental settings and results on three datasets.

#### A. Face Verification on LFW

1) Dataset and Settings: The LFW dataset [9] contains more than 13000 face images of 5749 subjects collected from the web with large variations in expression, pose, age, illumination, resolution, etc. There are two training paradigms for supervised learning on this dataset: *image restricted* and *image unrestricted*. In our experiments, we used the *image restricted* setting where only the pairwise label information is provided to train our methods. We followed the standard evaluation protocol on the "View 2" dataset [9] which consists of 3000 matched pairs (or positive pairs) and 3000 mismatched pairs (or negative pairs), and all these pairs were divided into 10 folds and each fold contains 300 positive pairs and 300 negative pairs of face iamges. We used the LFW-a dataset for our experimental evaluation, and thus our setting on this dataset falls into the category of *image-restricted*, *label-free outside data*. For each face image, we first cropped it into  $80 \times 150$ pixels from its center to remove the background information, and then extracted three types of feature representations:

- Dense SIFT (DSIFT) [35]: Firstly, we densely sampled SIFT descriptors on each  $16 \times 16$  patch without overlapping and obtained 45 SIFT descriptors. Then, we concatenated these SIFT descriptors to form a 5760-dimensional feature vector;
- LBP [23]: We divided each image into 8×15 nonoverlapping blocks, where the size of each block is 10×10. Then, we extracted a 59-dimensional uniform pattern LBP feature for each block and concatenated them to form a 7080-dimensional feature vector;
- Sparse SIFT (SSIFT): We used SSIFT feature provided by [1], which first localized nine fixed landmarks in each image and extracted SIFT descriptors over three scales at these landmarks, and then concatenated these 27 SIFT descriptors to result a 3456-dimensional vector.

For these three kinds of features, we employed whitened PCA (WPCA) to project each feature vector into a 200-dimensional feature subspace, respectively. Note that we first employed the WPCA on the training set to compute the projection matrix, and then we used this projection matrix to reduce the dimension of each sample in the training set and testing set.

2) Comparison with Baseline Methods: Table I records the verification accuracy with standard error of our methods and baseline methods by different metric learning strate-

TABLE I Comparisons of the mean verification accuracy (%) with several baseline methods on the LFW under category of image-restricted, label-free outside data.

Method	Feature	Accuracy (%)
SML	DSIFT	$84.30 \pm 0.69$
SML	LBP	$83.83 \pm 0.41$
SML	SSIFT	$84.58 \pm 0.36$
CML	All	$82.40 \pm 0.51$
IML	All	$87.78 \pm 0.58$
LML	DSIFT	$86.33 \pm 0.66$
LML	LBP	$85.98 \pm 0.44$
LML	SSIFT	$86.75 \pm 0.34$
LM <sup>3</sup> L	All	$89.57 \pm 0.48$
$L^2 M^3 L$	All	$90.23 \pm 0.55$

gies on the LFW dataset under category of image-restricted, label-free outside data. We see that the LM<sup>3</sup>L and  $L^2M^3L$ methods consistently outperforms these baseline methods in terms of the mean verification accuracy. Compared with SML (or LML), the LM<sup>3</sup>L (or L<sup>2</sup>M<sup>3</sup>L) learns multiple distance metrics with multi-feature representations, such that more discriminative information can be exploited for verification. Compared with CML and IML, our LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L jointly learn multiple distance metrics so that the distance metrics learned for different features can interact each other, therefore more complementary information can be extracted for face verification. We also observe that local metric leaning methods (i.e., LML and  $L^2M^3L$ ) obtain the better performance than their global companions (i.e., SML and LM<sup>3</sup>L). These results show that the LML and L<sup>2</sup>M<sup>3</sup>L can exploit local specificities of data to improve performance of face verification.

3) Comparison with State-of-the-Art Methods: We also compared our LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L methods with several stateof-the-art methods on the LFW dataset. These methods can be categorized into metric learning based methods containing PCCA [27], DML-eig combined [36], CSML+SVM [7], SFRD+PMML [6], Sub-SML [19], large margin local metric learning (LMLML) [31], and discriminative deep metric learning (DDML) [37]; and descriptor based methods including pose adaptive filter (PAF) [38], high dimensional vector multiplication (VMRS) [39], Hybrid on LFW3D [40], and Spartans [41]. Table II tabulates the mean verification accuracy with standard error of different methods and Fig. 1 shows ROC curves of several state-of-the-art methods on this dataset. We see that the proposed LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L methods achieve competitive results compared with these state-of-theart methods except two methods: Sub-SML + Hybrid on LFW3D [40] and HPEN + HD-LBP + DDML [11]. The reason is that they both employed the powerful face alignment techniques, and Sub-SML + Hybrid on LFW3D [40] adopted more than 10 types of features and HPEN + HD-LBP + DDML [11] exploited the over-complete high-dimensional feature (i.e., 100K-dim HD-LBP) for face verification.

The reason that VMRS [39] outperforms  $L^2M^3L$  is that: 1) VMRS adopted 10 different features (i.e., LBP, TPLBP, OCLBP, SIFT, Scattering, and their "sqrt root" versions); 2) VMRS used high-dimensional features, e.g., the 40887dimensional OCLBP, and the 96520-dimensional Scattering

TABLE II Comparisons of the mean verification accuracy (%) with state-of-the-art results on the LFW under category of image-restricted, label-free outside data, where NoF denotes the number of feature used in each method.

Method	NoF	Accuracy (%)
PCCA [27]	1	$83.80 \pm 0.40$
Hybrid on LFW3D [40]	12	$85.63 \pm 0.53$
DML-eig combined [36]	8	$85.65\pm0.56$
LMLML [31]	1	$86.13 \pm 0.53$
PAF [38]	1	$87.77\pm0.51$
CSML+SVM [7]	6	$88.00 \pm 0.37$
SFRD+PMML [6]	8	$89.35 \pm 0.50$
Spartans [41]	1	$89.69 \pm 0.36$
Sub-SML [19]	6	$89.73 \pm 0.38$
TSML with feature fusion [42]	12	$89.80 \pm 0.47$
DDML [37]	6	$90.68 \pm 1.41$
VMRS [39]	10	$91.10 \pm 0.59$
Sub-SML + Hybrid on LFW3D [40]	12	$91.65 \pm 1.04$
HPEN + HD-LBP + DDML [11]	1	$92.57 \pm 0.36$
LM <sup>3</sup> L	3	$89.57 \pm 0.48$
L <sup>2</sup> M <sup>3</sup> L	3	$90.23 \pm 0.55$

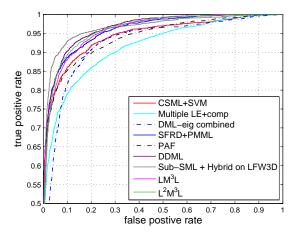


Fig. 1. ROC curves of our methods and several state-of-the-art methods on the LFW under category of image-restricted, label-free outside data.

feature; and 3) VMRS combined the non-linear dimensionality reduction technique called Diffusion Maps (DM) [39] and WPCA to obtain an additional improvement in accuracy. In our methods, we used three low-dimensional features, where the WPCA is used to reduce the dimensionality. The reason that the performance of DDML [37] outperforms  $L^2M^3L$  is that 1) The DDML employs 6 different features; and 2) The DDML adopts a nonlinear distance metric learning method via the neural network to exploit the nonlinearity of data points. In our methods, we use three low-dimensional features to learn several linear distance metrics.

4) Comparison of  $LM^3L$  and  $L^2M^3L$  with  $\lambda = 0$ : When  $\lambda = 0$ , we evaluated the  $LM^3L$  ( $\lambda = 0$ ) and  $L^2M^3L$  ( $\lambda = 0$ ) on LFW dataset under category of image-restricted, label-free outside data (see Table III). Table III shows that the regularization term of the  $LM^3L$  and  $L^2M^3L$  can help improve the verification accuracy. The reason is that the  $LM^3L$  and  $L^2M^3L$  seek a commonality of multiple features and make all features more robust for face verification.

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TABLE III Comparison of LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L when  $\lambda = 0$  on LFW dataset under category of image-restricted, label-free outside data.

Method	Feature	Accuracy (%)		
$LM^{3}L (\lambda = 0)$	LBP, DSIFT, SSIFT	$88.02\pm0.56$		
LM <sup>3</sup> L		$89.57 \pm 0.48$		
$L^2 M^3 L (\lambda = 0)$	LBP, DSIFT, SSIFT	$88.95 \pm 0.60$		
$L^2M^3L$		$90.23 \pm 0.55$		

TABLE IV Comparison of the Mean verification accuracy (%) with baseline methods using different metric learning strategies on the YTF under the image restricted setting.

Method	Feature	Accuracy (%)
SML	CSLBP	$73.66 \pm 1.52$
SML	FPLBP	$75.02 \pm 1.67$
SML	LBP	$78.46 \pm 0.94$
CML	All	$75.36 \pm 2.37$
IML	All	$80.12 \pm 1.33$
LML	CSLBP	$75.76 \pm 1.59$
LML	FPLBP	$75.78 \pm 2.19$
LML	LBP	$80.08 \pm 2.06$
LM <sup>3</sup> L	All	$81.28 \pm 1.17$
L <sup>2</sup> M <sup>3</sup> L	All	$81.72 \pm 1.53$

## B. Video-based Face Verification on YTF

1) Dataset and Settings: The YTF dataset [10] consists of 3425 videos of 1595 different people collected from YouTube site. There are also large variations in pose, illumination, and expression in each video, and the average length of each video clip is 181.3 frames. In our experiments, we followed the standard evaluation protocol and evaluated our methods for unconstrained video-based face verification on the 5000 video pairs. These 5000 pairs are equally divided into 10 folds and each fold contains 250 intra-personal pairs (positive pairs) and 250 inter-personal pairs (negative pairs). We adopted the *image restricted* and *image unrestricted* protocols to evaluate the proposed methods. For the image restricted setting, we directly used three feature descriptors including LBP, Center-Symmetric LBP (CSLBP) [10] and Four-Patch LBP (FPLBP) [43] which are provided by [10]. Since all face images have been aligned by the detected facial key points, we simply averaged all the feature vectors within one video clip to result a mean feature vector for each type of feature. Then, we employed WPCA to reduce each feature into a 200dimensional feature vector.

2) Comparison with Baseline Methods: As in LFW dataset, we also compared our methods with several baseline methods using different metric learning strategies, i.e., SML, CML and IML on the YTF dataset under the image restricted setting. Table IV records the mean verification accuracy with standard error of these metric learning methods on the YTF under the image restricted setting. We see that the proposed LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L methods consistently perform better than these baseline methods in terms of the mean verification accuracy; and local based methods, LML and L<sup>2</sup>M<sup>3</sup>L, can make use of local structures of samples to enhance the verification accuracy. These two observations are in agreement with results obtained on the LFW dataset.

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TABLE V Comparisons of the mean verification accuracy with standard error (%) with several state-of-the-art results on the YTF under the image restricted setting.

Method	Accuracy (%)
MBGS (LBP) [10]	$76.40 \pm 1.80$
APEM (LBP) [24]	$77.44 \pm 1.46$
APEM (fusion) [24]	$79.06 \pm 1.51$
STFRD+PMML [6]	$79.48 \pm 2.52$
$MBGS+SVM \ominus [44]$	$78.90 \pm 1.90$
VSOF+OSS (Adaboost) [45]	$79.70 \pm 1.80$
DDML (combined) [37]	$82.34 \pm 1.47$
LMKMML [48]	$82.70 \pm 1.50$
DMM+CFN [47]	$82.80\pm0.90$
Eigen-PEP [46]	$84.80 \pm 1.40$
LM <sup>3</sup> L	$81.28 \pm 1.17$
$L^2M^3L$	$81.72 \pm 1.53$

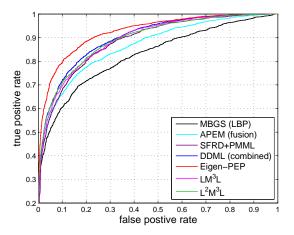


Fig. 2. ROC curves of our methods and several state-of-the-art methods on the YTF under the image restricted setting.

3) Comparison with State-of-the-Art Methods: We then compared LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L with state-of-the-art methods on the YTF dataset under the image restricted setting. The compared methods include matched background similarity (MBGS) [10], APEM [24], STFRD+PMML [6], MBGS+SVM⊖ [44], VSOF+OSS (Adaboost) [45], DDML [37], Eigen-PEP [46], deep mixture model and convolutional fusion network (DMM+CFN) [47], and LMKMML [48]. Table V lists the mean verification accuracy with the standard error, and Fig. 2 shows ROC curves of our methods and several state-of-the-art methods on the YTF dataset, respectively. We can observe that our L<sup>2</sup>M<sup>3</sup>L method achieves competitive results compared with most of these state-of-the-art methods on this dataset under the image restricted setting. Additionally, the Eigen-PEP obtains the best accuracy, the reason is that it exploits intra-class variations between frames of each video clip while our implementation simply takes the mean of all frames for a video in feature representation.

4) Comparison with Deep Learning based Methods: We also evaluated our LML, LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L methods using convolutional neural network (CNN) feature which recently has achieved various promising results on face verification [2], [12], [13]. In our implementation, we employed the VGG-Face CNN model provided by [13] to compute CNN descriptor.

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TABLE VI Comparison with deep learning based methods on the YTF dataset under image unrestricted setting.

Method	Feature	Accuracy (%)
SML	CNN	$93.92 \pm 1.18$
LML	CNN	$94.56 \pm 1.24$
LM <sup>3</sup> L	CNN, CSLBP, FPLBP, LBP	$94.75 \pm 1.21$
L <sup>2</sup> M <sup>3</sup> L	CNN, CSLBP, FPLBP, LBP	$94.90 \pm 1.09$
DFD-SID+JB [49]	CNN	$89.10\pm0.40$
DeepFace-single [2]	CNN	$91.4 \pm 1.1$
FaceNet [12]	CNN	$95.12 \pm 0.39$
Softmax (L2) [13]	CNN	91.6
Embedding loss [13]	CNN	97.3

Specifically, we only extracted CNN feature on the first 100 frames of each video at single scale. For each face image in YTF dataset, we first resized it to size of  $200 \times 200$  pixels and cropped  $100 \times 100$  region from its center, then we resized it to  $224 \times 224$  pixel image to compute 4096-dimensional CNN feature vector. Finally, we averaged these CNN feature vectors of the first 100 frames for each video, and each video was represented by a 4096-dimensional vector. Moreover, each feature vector was reduced to the size of 200 by PCA. Table VI shows the mean verification accuracy of our proposed methods and several deep learning based methods using CNN feature (e.g., DeepFace [2], FaceNet [12], and VGG-Face CNN [13]) on the YTF under the image unrestricted setting. We see that our LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L can be comparable to these state-of-the-art results on this dataset under this unrestricted setting.

The Face Net [12] and Embedding loss [13] are two current state-of-the-art methods on YTF dataset. The reason that they outperformed  $L^2M^3L$  is that:

- The Face Net [12] used about 200 million face images in the model training, and the VGG-Face CNN model used in our method used about 2.6 million face images.
- To extract CNN features for each face video, the Embedding loss [13] selected the top 100 frames of this video by ordering the faces by their facial landmark confidence score. In our L<sup>2</sup>M<sup>3</sup>L, we only took the first 100 frames by following the setting in the Face Net [12].
- The Face Net [12] and Embedding loss [13] are two strongly-supervised learning methods, because they employ the triplet loss function which exploits the label information of each face video of YTF dataset. Unlike these methods, our L<sup>2</sup>M<sup>3</sup>L method is a weaklysupervised learning method which only exploits the pairwise supervision from face video pairs.

In Table VI, the main aim of  $L^2M^3L$  and LML is to show that 1) our metric learning methods learn the favorable distance metrics to improve the performance of Softmax (L2) [12] (91.6%) when the CNN feature is used; and 2)  $L^2M^3L$  can further improve the verification accuracy by integrating low-level features and high-level features into a unified framework.

## C. Kinship Verification on KinFaceW-II

1) Dataset and Settings: The KinFaceW-II [5] is a kinship face dataset collected from the public figures or celebrities and their parents or children. There are four kinship relations in

TABLE VII Comparisons of the mean verification accuracy (%) with baseline methods using different metric learning strategies on the KinFaceW-II dataset.

Method	Feature	F-S	F-D	M-S	M-D	Mean
SML	LE	76.2	70.1	72.4	71.8	72.6
SML	LBP	66.9	65.5	63.1	68.3	66.0
SML	TPLBP	71.8	63.3	63.0	67.6	66.4
SML	SIFT	68.1	63.8	67.0	63.9	65.7
CML	All	76.3	67.5	74.3	75.4	73.4
IML	All	79.4	71.5	76.3	77.3	76.1
LML	LE	76.8	74.2	76.6	73.8	75.4
LML	LBP	66.0	64.8	67.8	66.8	66.4
LML	TPLBP	68.6	66.2	65.4	70.8	67.8
LML	SIFT	72.2	66.0	68.2	66.2	68.2
LM <sup>3</sup> L	All	82.4	74.2	79.6	78.7	78.7
L <sup>2</sup> M <sup>3</sup> L	All	82.4	78.2	78.8	80.4	80.0

the KinFaceW-II datasets: Father-Son (F-S), Father-Daughter (F-D), Mother-Son (M-S) and Mother-Daughter (M-D), and each relation includes 250 pairs of kinship images. Following the experimental settings in [5], we constructed 250 positive pairs (with kinship) and 250 negative pairs (without kinship) for each relation. For each face image, we extracted four types of feature representations as follows:

- LEarning-based descriptor (LE) [50]: Following the same parameter settings used in [50], [5], we first obtained 200 cluster centers by k-means clustering, and then performed vector quantization to obtain a 200-bin histogram feature for the whole face image;
- LBP: A 256-bin histogram feature was extracted;
- TPLBP [43]: We obtained a 256-bin histogram feature for each image by adopting the default setting in [43].
- SIFT: We densely sampled SIFT descriptors on 16×16 blocks with space of 8 pixels, and then computed a 200-bin histogram feature for each image by adopting the bag-of-visual-words model.

We adopted the 5-fold cross validation strategy for each of the four relations in this dataset and the final results were reported by the mean verification accuracy.

2) Comparison with Baseline Methods: We first compared our method with SML, CML, and IML on the KinFaceW-II dataset. Table VII records the mean verification accuracy of our methods and baseline methods using various metric learning strategies on the KinFaceW-II dataset for four kinship relations, respectively. We also see that the LML,  $LM^{3}L$ and  $L^{2}M^{3}L$  consistently outperforms baseline metric learning strategies on four relations in mean verification accuracy.

3) Comparison with Multiple Metric Learning Methods: We further compared the LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L methods with several multiple metric learning methods for kinship verification. These multiple metric learning methods include multiple canonical correspondence analysis (MCCA) [33], multiple NRML (MNRML) [5], discriminative multimetric learning (DMML) [20], and PMML [6]. Table VIII reports the mean verification accuracy of our methods and these multiple metric learning methods. We observe that L<sup>2</sup>M<sup>3</sup>L achieves about 1.7% improvement over DMML and 1.3% over LM<sup>3</sup>L in terms of the mean verification accuracy.

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TABLE VIII Comparisons of the mean verification accuracy (%) with several multiple metric learning methods on the KinFaceW-II dataset.

Method	Feature	F-S	F-D	M-S	M-D	Mean
MCCA [33]	All	74.0	72.1	74.8	75.3	74.1
PMML [6]	All	77.7	72.4	76.3	74.8	75.3
MNRML [17]	All	76.9	74.3	77.4	77.6	76.5
DMML [20]	All	78.5	76.5	78.5	79.5	78.3
LM <sup>3</sup> L	All	82.4	74.2	79.6	78.7	78.7
$L^2M^3L$	All	82.4	78.2	78.8	80.4	80.0

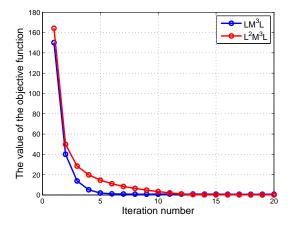


Fig. 3. The value of the objective function of  $LM^3L$  and  $L^2M^3L$  versus different number of iterations on the LFW dataset.

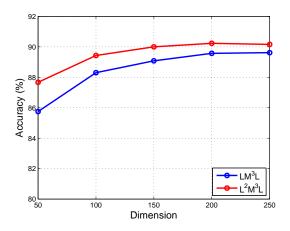
## D. Discussion and Parameter Analysis

We examined several parameters that may affect the performance of the  $LM^{3}L$  and  $L^{2}M^{3}L$  methods on the LFW dataset under category of image-restricted, label-free outside data.

1) Convergence Analysis: We first evaluated the convergence of the LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L methods with different number of iterations. Fig. 3 shows the value of the objective function of the LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L versus different number of iterations on the LFW dataset. We see that the convergence speed of our methods is acceptable. The LM<sup>3</sup>L converges in  $5 \sim 6$ iterations and the L<sup>2</sup>M<sup>3</sup>L method begins to keep stable after the 10 iterations on the training set.

2) Effect of Different Feature Dimensions: Then we investigated the performance of the LM<sup>3</sup>L and large-margin versus different feature dimensions. Fig. 4 shows the mean verification accuracy of our multi-metric learning methods versus different feature dimensions on the LFW dataset. We notice that our methods can achieve stable performance when the feature dimension of various features reaches 200. This is the reason that we select 200 dimension for each feature via WPCA in our experiments on this dataset.

3) Effect of Different Number of Local Metrics: Lastly, we evaluated how the various number of local metrics (i.e.,  $Q_k$ ) affects the LML and  $L^2M^3L$  methods. For the LML method, we chose SSIFT feature for this evaluation due to its good performance. Fig. 5 lists the mean verification accuracy versus various  $Q_k$  on the LFW dataset. We see that increasing  $Q_k$  improves the accuracy of LML and  $L^2M^3L$ , but the performance of our local metric learning based methods



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Fig. 4. The mean verification accuracy of  $LM^3L$  and  $L^2M^3L$  versus different feature dimensions on the LFW dataset.

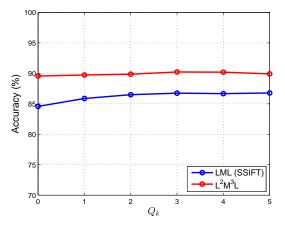


Fig. 5. The mean verification accuracy of LM<sup>3</sup>L and L<sup>2</sup>M<sup>3</sup>L versus various  $Q_k$  (i.e., number of local metrics) on the LFW dataset.

remains stable or may even degrade if a too large number of local metrics is adopted. The reason may be that learning more local metrics requires a sufficient number of training samples in model training. In the experiments, we adopted three local metrics because it not only obtains acceptable results but also reduces the computational time.

## VI. CONCLUSION

In this paper, we have introduced a large-margin multimetric learning  $(LM^3L)$  method for face and kinship verification under unconstrained conditions. The  $LM^3L$  jointly learns multiple distance metrics under which more discriminative and complementary information can be exploited. Moreover, to better exploit the local structures of face images, we have proposed a local metric learning (LML) and a local largemargin multi-metric learning  $(L^2M^3L)$  methods to learn a set of local metrics. Experimental results on three datasets show that our method can achieve competitive results compared with the state-of-the-art methods. For future work, we are interested in applying our methods to other computer vision applications such as person re-identification, action recognition and object tracking to further show their effectiveness. 12

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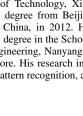
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